Search Notes			
			ŀ

Application/Control No.	Applicant(s)/Patent Reexamination	t under
10/660,422	AGBABIAN ET AL	
Examiner	Art Unit	
Anil Khatri	2191	

SEARCHED			
Class	Subclass	Date	Examiner
717	108-110	12/3/2007	AK
717	116-117	12/3/2007	AK
717	120-123	12/3/2007	AK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
717	108	12/3/2007	AK
717	116	12/3/2007	AK
	-H		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East	12/3/2007	AK
ACM/IEEE	12/3/2007	AK
Inventor search, DP search 11/680031	12/3/2007	AK
Consulted with SPE Wei Zhen for allowable sub. matter	11/27/2007	AK